

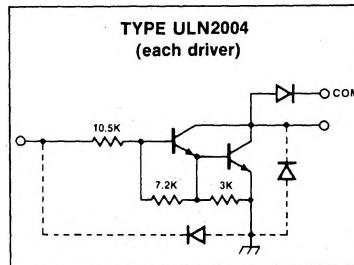
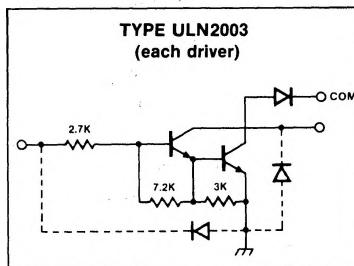
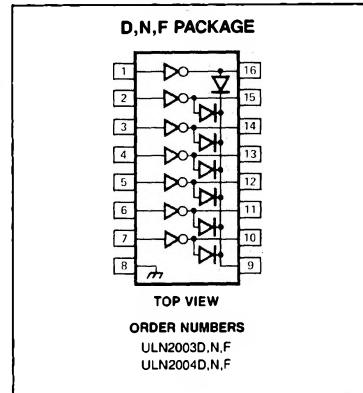
DESCRIPTION

These high-voltage, high-current Darlington transistor arrays are comprised of seven silicon NPN Darlington pairs on a common monolithic substrate. All units feature open collector outputs and integral suppression diodes for inductive loads. Peak inrush currents to 600mA are allowable, making them ideal for driving tungsten filament lamps also.

The Type ULN2003 has a series base resistor to each Darlington pair, and thus allows operation directly with TTL or CMOS 5V supply voltage.

The Type ULN2004 has an appropriate series input resistor to allow its operation directly from CMOS or PMOS outputs utilizing supply voltages of 6 to 15V. The required input current is below that of the Type ULN2003.

In all cases, the individual Darlington pair collector current rating is 500mA. However, outputs may be paralleled for higher load current capability. All devices are supplied in a 16-pin dual in-line plastic package.

EQUIVALENT SCHEMATICS**PIN CONFIGURATION****FEATURES**

- Peak inrush current 600mA
- Protected internally against inductive loads
- Open collector topology
- Compatible with most logic technologies

ABSOLUTE MAXIMUM RATINGS

at 25°C Free-Air temperature for any one Darlington pair unless otherwise specified.

PARAMETER	RATING	UNIT	
V _{CE}	Output voltage	50	V
V _{IN}	Input voltage	30	V
V _{EBO}	Emitter base voltage	6	V
I _C	Continuous collector current	500	mA
I _B	Continuous base current	25	mA
P _D	Power dissipation	1.3	W
	Derating factor above 25°C	95	°C/W
T _A	Ambient temperature range (operating)	0 to +85	°C
T _S	Storage temperature range	-65 to +150	°C

***NOTE**

Under normal operating conditions, these units will sustain 350mA per output with $V_{CE(SAT)} = 1.6V$ at 70°C with a pulse width of 20 ms and a duty cycle of 30%.

HIGH VOLTAGE/HIGH CURRENT DARLINGTON TRANSISTOR ARRAYS

ULN2003/04

DC ELECTRICAL CHARACTERISTICS $T_A = 25^\circ C$ unless otherwise specified.^{1,2,3}

PARAMETER	TEST CONDITIONS	Test Fig.	LIMITS			UNIT
			Min	Typ	Max	
I _{CEx}	Output leakage current Type ULN2004	V _{CE} = 50V, T _A = 70°C V _{CE} = 50V, T _A = 70°C, V _{IN} = 1V	1A 1B	— —	— —	100 500 μA
V _{CESAT}	Collector-emitter Saturation voltage	I _C = 350mA, I _B = 500 μA I _C = 200mA, I _B = 350 μA I _C = 100mA, I _B = 250 μA	2 2 2	— — —	1.25 1.1 0.9	1.6 1.3 1.1 V
I _{IN(ON)}	Input current Type ULN2003 Type ULN2004	V _{IN} = 3.85V V _{IN} = 5V V _{IN} = 12V	3 3 3	— — —	0.93 0.35 1.0	1.35 0.5 1.45 mA
I _{IN(OFF)}	Input current	I _C = 500 μA , T _A = 70°C	4	50	65	— μA
V _{IN(ON)}	Input voltage					
	Type ULN2003	V _{CE} = 2V, I _C = 200mA V _{CE} = 2V, I _C = 250mA V _{CE} = 2V, I _C = 300mA	5 5 5	— — —	2.4 2.7 3.0	2.4 2.7 3.0 V
	Type ULN2004	V _{CE} = 2V, I _C = 125mA V _{CE} = 2V, I _C = 200mA V _{CE} = 2V, I _C = 275mA V _{CE} = 2V, I _C = 350mA	5 5 5 5	— — — —	5.0 6.0 7.0 8.0	5.0 6.0 7.0 8.0 V
C _{IN}	Input capacitance		—	—	15	30 pF
I _R	Clamp diode leakage current	V _R = 50V	6	—	—	50 μA
V _F	Clamp diode forward voltage	I _F = 350mA	7	—	1.7	2 V

NOTES

- All limits stated apply to the complete Darlington series except as specified for a single device type
- The I_{IN(OFF)} current limit guarantees against partial turn-on of the output
- The V_{IN(ON)} voltage limit guarantees a minimum output sink current per the specified test conditions

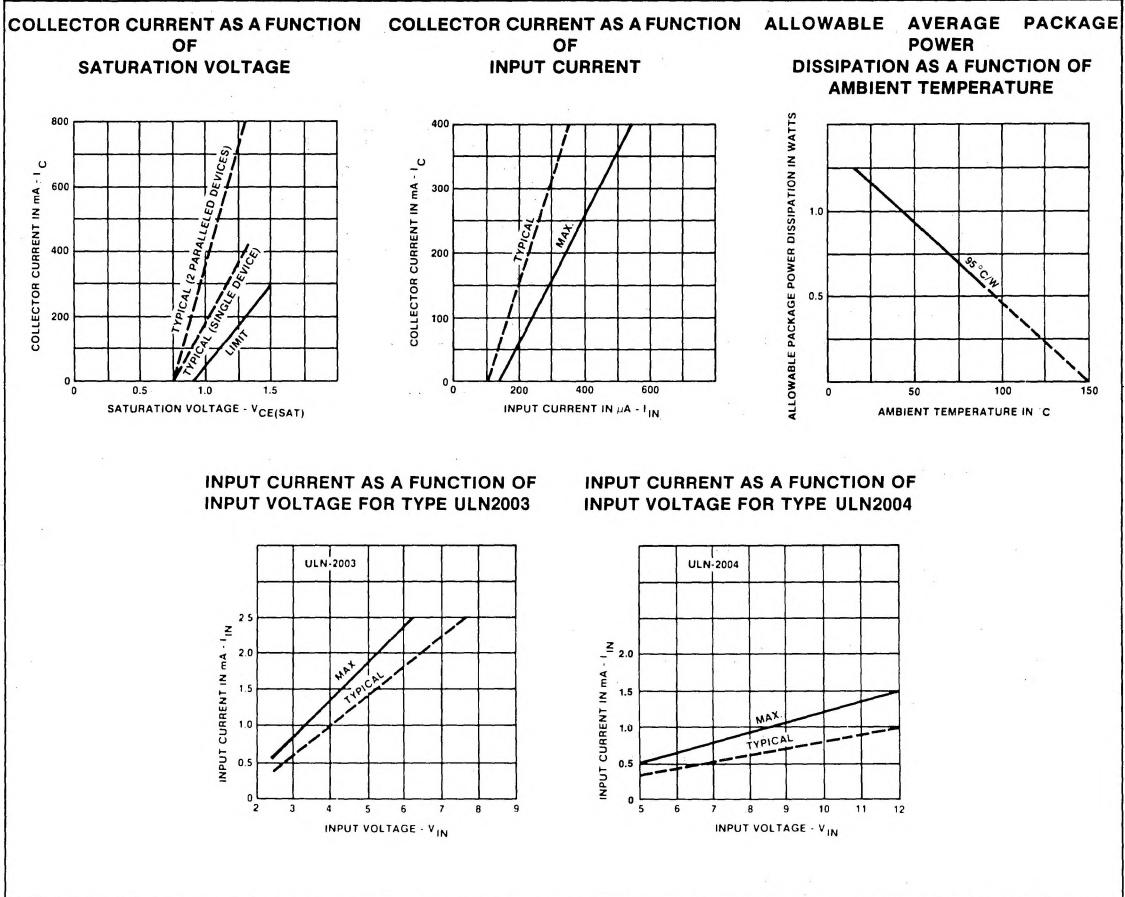
AC ELECTRICAL CHARACTERISTICS $T_A = 25^\circ C$ unless otherwise specified.^{1,2,3}

PARAMETER	TEST CONDITIONS	Test Fig.	LIMITS			UNIT
			Min	Typ	Max	
t _{PLH}	Turn-on delay	0.5 E _{IN} to 0.5 E _{OUT}	—	—	1.0	5 μs
t _{PHL}	Turn-off delay	0.5 E _{IN} to 0.5 E _{OUT}	—	—	1.0	5 μs

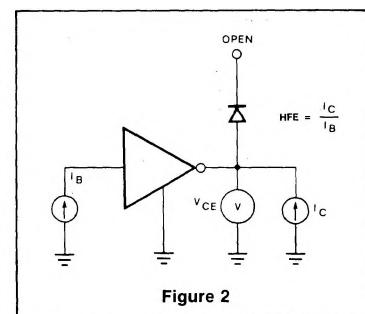
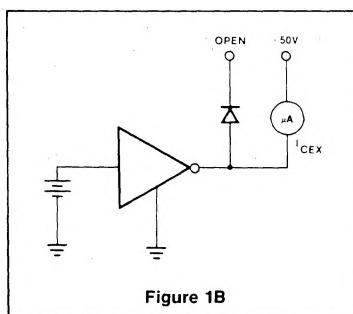
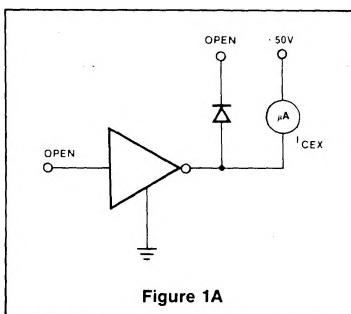
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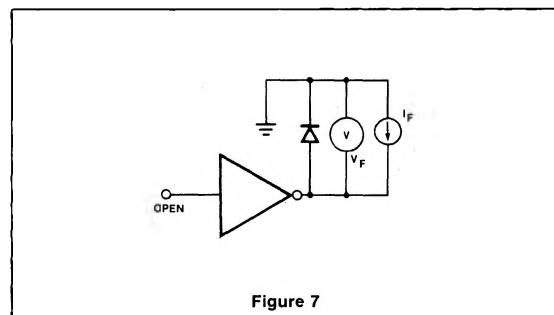
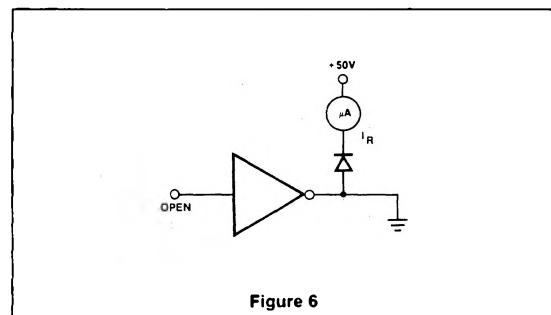
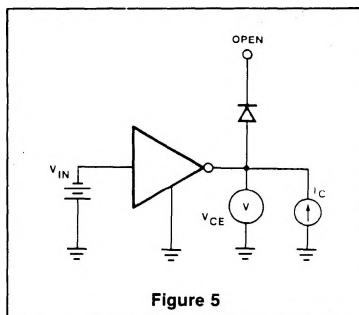
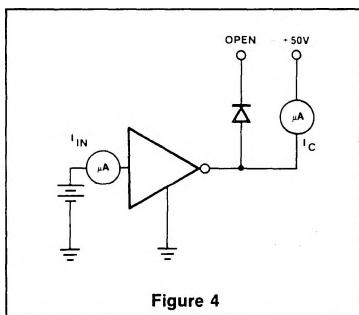
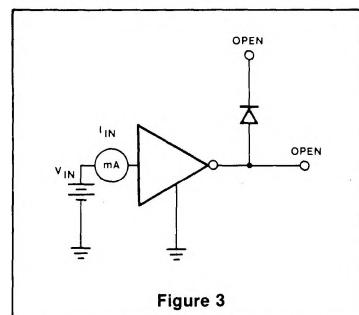
TYPICAL PERFORMANCE CHARACTERISTICS



TEST FIGURES



TEST FIGURES (Cont'd)



TYPICAL APPLICATIONS

